

## **Electroconductive properties monitoring after oxidation of a $ZrB_2$ ceramic material**

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### **Abstract**

The electroconductive properties of a  $ZrB_2$  ceramic material were investigated before and after oxidation. This material has recently gained new interest thanks to a combination of attracting properties such as high melting point, high hardness and wear resistance with low electrical resistivity. The latter allows applying electrical discharge machining (EDM) for the production of small precision parts with complex geometry.

A fully dense  $ZrB_2$  was produced by hot pressing at  $1700^\circ\text{C}$  with  $Si_3N_4$  as sintering aid. The material was subjected to oxidation in flowing oxygen in the range of temperatures  $850\text{-}1100^\circ\text{C}$ . The oxidation kinetic changes from logarithmic, at  $850^\circ\text{C}$ , to parabolic behavior for temperatures up to  $1100^\circ\text{C}$ . At lower temperatures an oxide scale develops, which blocks the oxygen diffusion and prevents further corrosion. At higher temperatures a growing layer of monoclinic Zirconia forms. The parabolic gain due to the formation of  $ZrO_2$  is superimposed to the linear evaporation of boric oxide.

In order to evaluate the change in resistivity of the oxidized material a two-point method was used on bars with the oxide layer removed from the ends.

The change in resistivity of oxidized samples is much higher than predicted from a simple change in cross-section, due to the formation of the corrosion layer. Therefore a zone extending far deeper under the corrosion layer should be responsible for the decrease in conductivity.

Cross sections of the oxidized material were analyzed with scanning electron microscopy (SEM) and Raman spectroscopy to understand the mechanisms connected with changes in electroconductive properties.